DATA SHEET



PHOTO TRANSISTOR PH116 (L)

SMALL PACKAGE TYPE PHOTO TRANSISTOR

PH116(L) is a small type hige sensitivity photo transistor molded with black resin. By using resin with a property of visible light cutting filter, the light receiving sensitivity of the device becomes active from a wavelength of approximately 820nm, and the device is not affected by an external light source as a fluorescent lanp.

PACKAGE DIMENSIONS (Unit: mm)

*)Residue after molding
PIN CONNECTIONS

1. Emitter
2. Collector

FEATURES

- Surface mount type
- High sensitivity $(I_L:40 \mu \text{A, min.} \text{ e V}_{CE}=5\text{V, H}=100 \mu \text{ W/cm}^2)$
- High spectral sensitivty (sensitivity active wavelength: 820nm, typ.)
- High-speed switching (tr=4 μs, tf=6 μme typ. eR_L=100Ω)
 ωS

QUALITY GRADE

Standard

Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

APPLICATIONS

- Various photo sensors
- Portable terminal

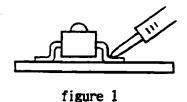
Bule line

HANDLING PRECAUTIONS:

Soldering

The full resin-molded PH1116(L) have generally a little mechanical and thermal strength than other resin-molded semiconductor devices as they have less additives. Therefore please note on the following points.

(a) Soldering of leads should be made at the point of leads, which is mounted on board (See figure 1) at $260 \, \text{C}$ and within 5 s.



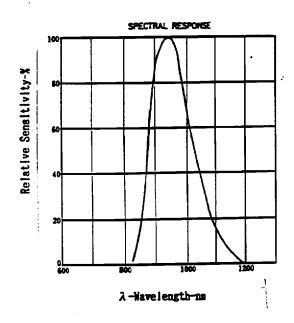
(b) If the temperature of the molded portion rises in addition to the residual stress between the leads, the possibility that open or short circuit occurs due to the deformation or destruction of the resin will increase.

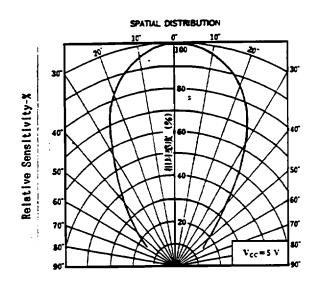
• On cleaning the device:

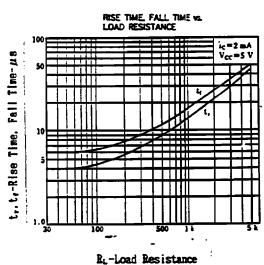
(a) Cleaning with unsuitable solvent may impair the resin of the package and the following solvents should be used at the temperature of less than 45°C and for less than 30 seconds minutes of immersion time.

Ethanol, Methanol Isopropyl-alcohol

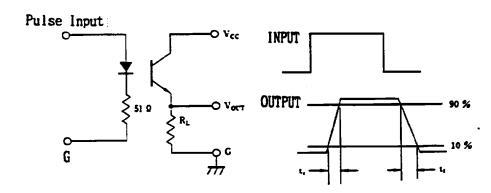
(b) Ultrasonic cleaning will add some stress on devices. The degree of the stress differs depending on the oscillation output power, the size of the PCB and the mounting methods of the devices, therefore it should be confirmed by making an experiment at actual coditions that the cleaning does not have any problem on the devices.



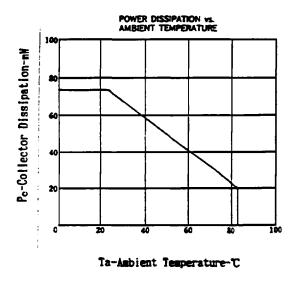


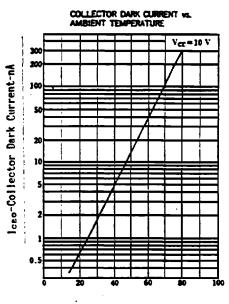


Test Circuit for Switching Time

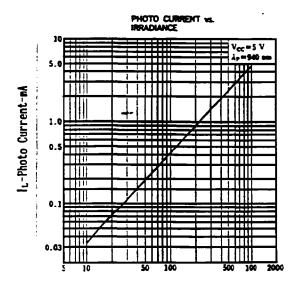


TYPICAL CHARACTERISTICS (Ta=25°C)

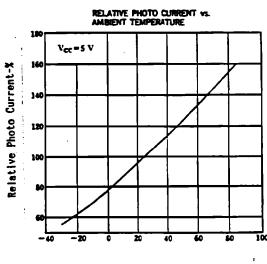












Ta-Ambient Temperature-T

ABSOLUTE MAXIMUM RATINGS (Ta=25°C)

Collector to Emitter Voltage	Vceo	30	V mA	
Collector Current	Ιc	25		
Collector Dissipation	Pe	7 5	m.W ℃	
Junction Temperature	T,	100		
Operating Temperature	Topt	-30 to +85	$\boldsymbol{\mathfrak{C}}$	
Storage Temperature	Tstg	-40 to +100	$\boldsymbol{\tau}$	

ELECTRO-OPTICAL CHARACTERISTICS (Ta=25°C)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Collector Dark Current	I czo			100	n A	Vcz=10V, H=0
Collector Saturation Voltage	VCE (mat)			0.4	V	$I_c=40 \mu$ A, H=100 μ W/cm ² *
Photo Current	IL	40	200		μΑ	$V_{CE}=5V$, $H=50 \mu \text{W/cm}^2*$
Rise Time	tr		4		μs	Vcc=5V, lc=2mA
Fall Time	Γf		6		μs	R _L =100Ω

^{*} With infrared ray of peak light emitting wavelength $\lambda = 940 nm$